



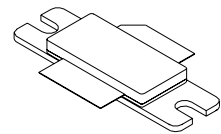
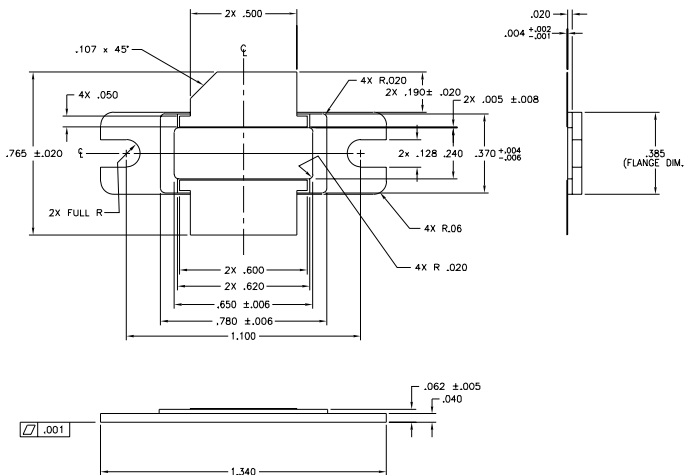
UPF2245

45W, 2.2GHz, 26.5V Broadband RF Power N-Channel Enhancement-Mode Lateral DMOS

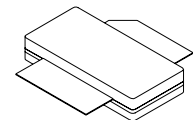
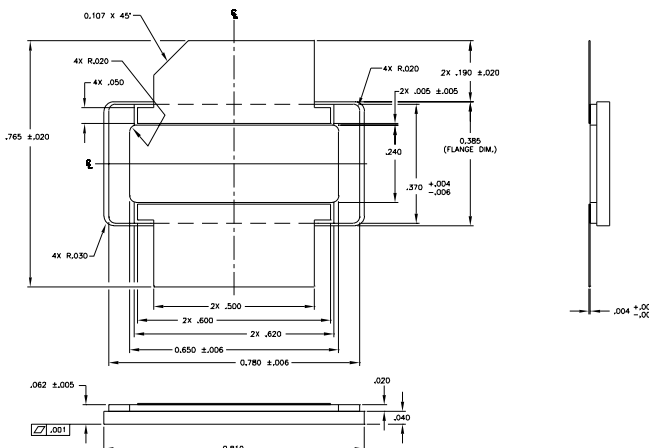
Description

This device is designed for base station applications operating at or near 2.2GHz. Rated with a minimum output power of 45W, it is ideal for CDMA, TDMA, GSM, FM, Single or Multi-Carrier Power Amplifiers in Class A or AB operation.

- Industry standard package.
- Low intermodulation distortion of -30dBc at 45W (PEP).
- Gold Metalization, Gold Bond Wires, Gold-Plated Packages.



Package Type 440117



Package Type 440133

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Maximum Ratings

Rating	Symbol	Value	Unit
Drain to Source Voltage, gate connected to source	V_{DSS}	65	Volts
Gate to Source Voltage	V_{GS}	± 20	Volts
Total Device Dissipation @ $T_{case} = 70^{\circ}C$ Derate above $70^{\circ}C$	P_D	100 0.8	Watts $W/^{\circ}C$
Storage Temperature Range	T_{STG}	-65 to +150	$^{\circ}C$
Operating Junction Temperature	T_J	200	$^{\circ}C$

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Thermal Characteristics

Characteristics	Symbol	Maximum	Unit
Thermal Resistance, Junction to Case	Θ_{JC}	1.3	$^{\circ}C/W$

Electrical DC Characteristics ($T_C=25^{\circ}C$ unless otherwise specified)

Rating	Symbol	Min	Typ	Max	Unit
Drain to Source Voltage, gate connected to source ($V_{GS}=0$, $I_{DS}=1mA$)	BV_{DSS}	65	-	-	Volts
Drain to Source Leakage current ($V_{DS}=28V$, $V_{GS}=0$)	I_{DSS}	-	-	2.0	mA
Gate to Source Leakage current ($V_{GS}=20V$, $V_{DS}=0$)	I_{GSS}	-	-	2.0	μA
Threshold Voltage ($V_{DS}=10V$, $I_{DS}=1mA$)	V_{TH}	2.0	3.0	5.0	Volts
Gate Quiescent Voltage ($V_{DS}=26V$, $I_{DS}=450mA$)	$V_{GS(on)}$	3.0	4.0	6.0	Volts
Drain to Source On Voltage ($V_{GS}=10V$, $I_{DS}=1A$)	$V_{DS(on)}$	-	0.14	-	Volts
Forward Transconductance ($V_{DS}=10V$, $I_D=5A$)	G_M	2.2	3.0	-	S

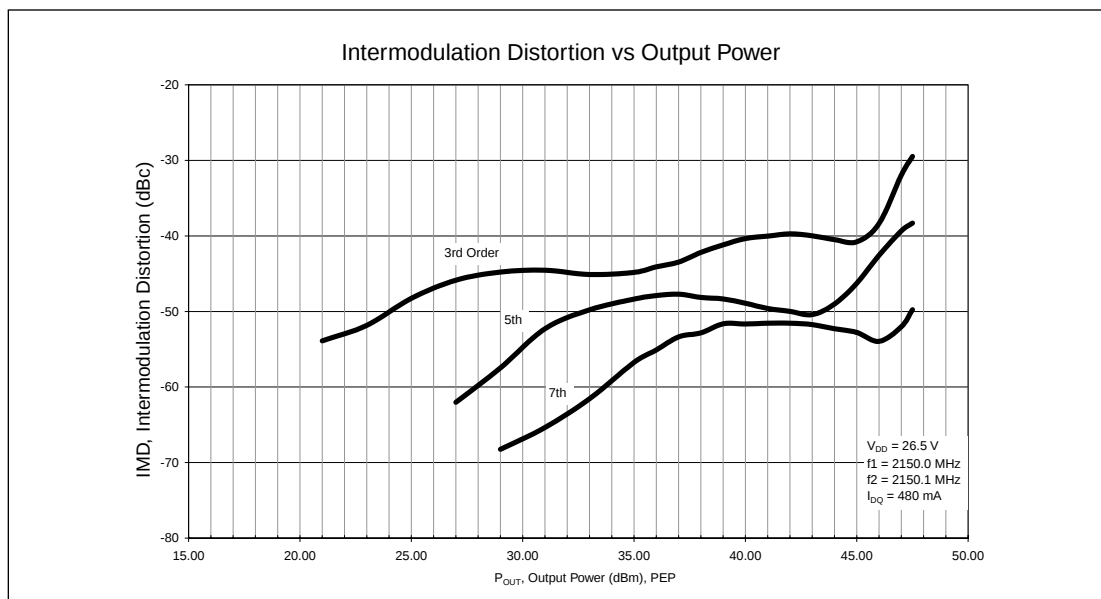
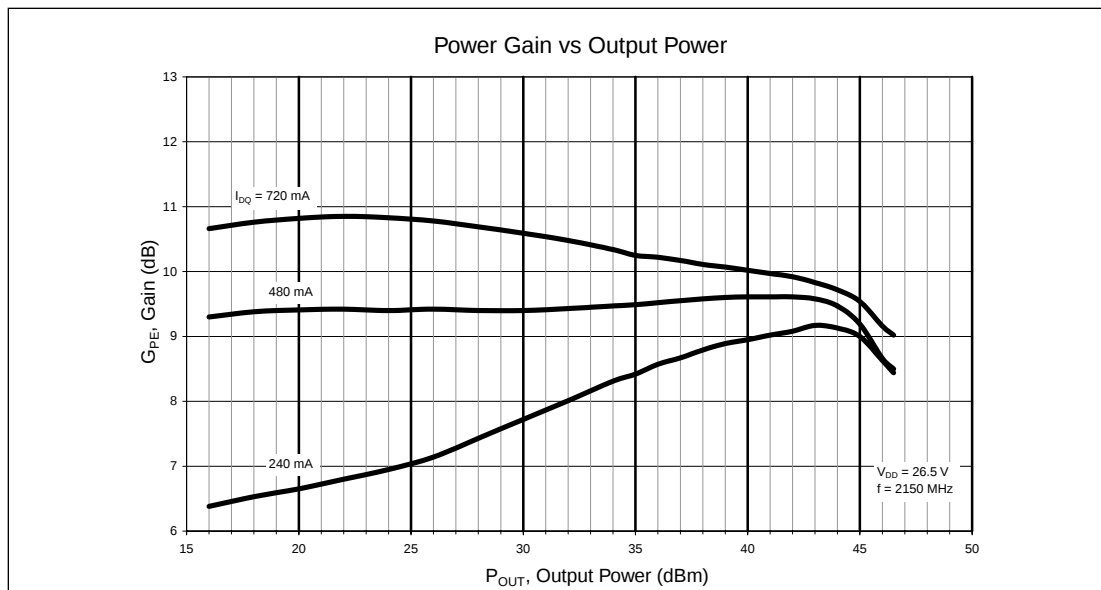
AC Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

Rating	Symbol	Min	Typ	Max	Unit
Output capacitance ($V_{DS}=26\text{V}$, $V_{GS}=0\text{V}$, freq= 1MHz)	C_{OSS}	-	62	-	pF
Feedback capacitance ($V_{DS}=26\text{V}$, $V_{GS}=0\text{V}$, freq= 1MHz)	C_{RSS}	-	2.8	-	pF

RF and Functional Tests ($T_C=25^\circ\text{C}$ unless otherwise specified, UltraRF Broadband Fixture)

Rating	Symbol	Min	Typ	Max	Unit
Linear Power Gain, Single tone ($V_{DS}=26.5\text{V}$, $I_{DQ}=480\text{mA}$, $P_{OUT}=10\text{W}$, $f=2150\text{ MHz}$)	G_{plin}	7.5	9.5	-	dB
Compressed Power Gain, Single Tone ($V_{DS}=26.5\text{V}$, $I_{DQ}=480\text{mA}$, $P_{OUT}=45\text{W}$, $f=2150\text{ MHz}$)	G_{ps}	7.0	8.5	-	dB
Drain Efficiency, Single Tone ($V_{DS}=26.5\text{V}$, $I_{DQ}=480\text{mA}$, $P_{OUT}=45\text{W}$, $f=2150\text{ MHz}$)	η	22	28	-	%
Intermodulation Distortion, Two Tone ($V_{DS}=26.5\text{V}$, $I_{DQ}=480\text{mA}$, $P_{OUT}=45\text{W PEP}$ $f_1=2150\text{ MHz}$, $f_2=2150.1\text{MHz}$)	IMD	-	-35	-30	dBc
Load Mismatch Tolerance ($V_{DS}=26.5\text{V}$, $I_{DQ}=480\text{mA}$, $P_{OUT}=45\text{W}$, $f=2150\text{ MHz}$)	VSWR	10:1	-	-	

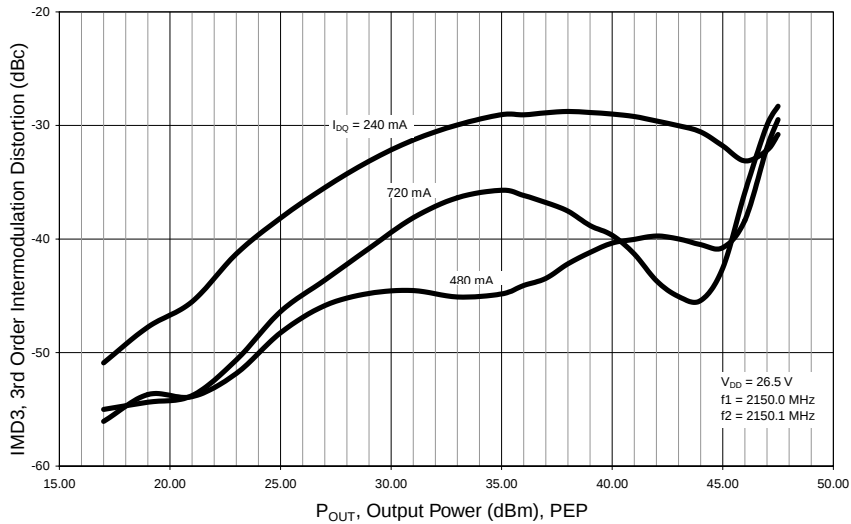
CAUTION - MOS Devices are susceptible to damage from ElectroStatic Discharge (ESD). Appropriate precautions in handling, packaging and testing MOS devices must be observed.



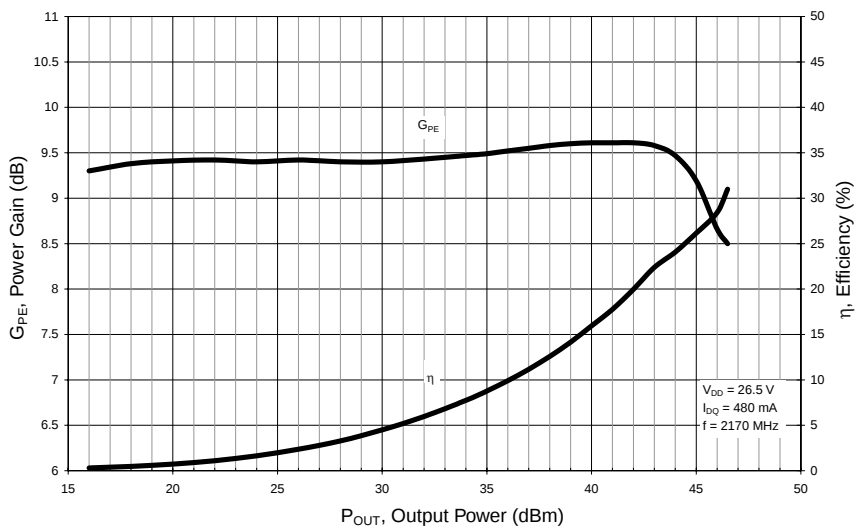
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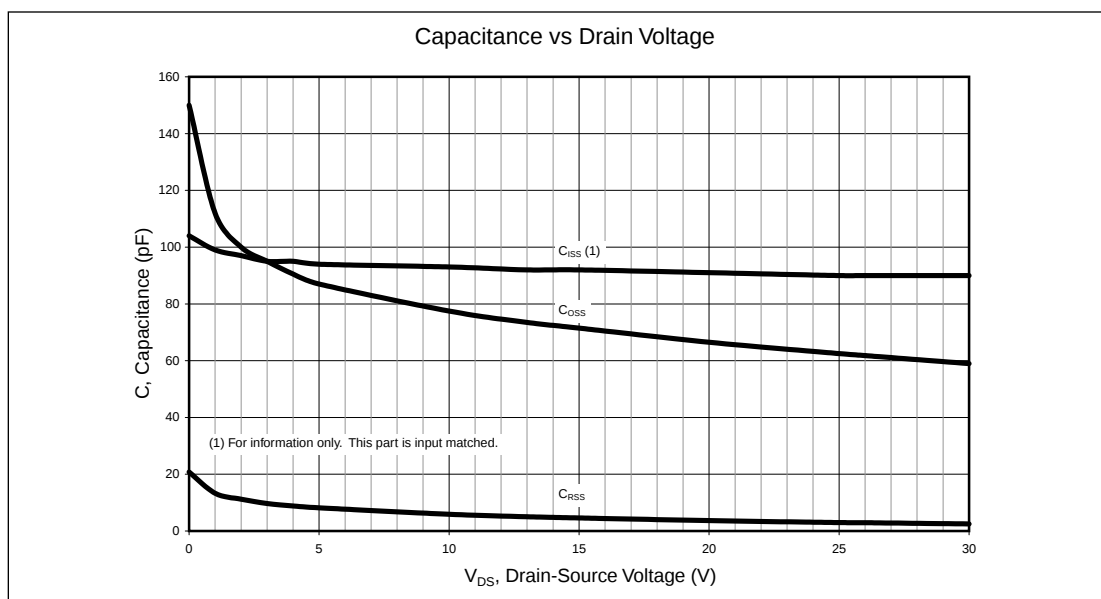
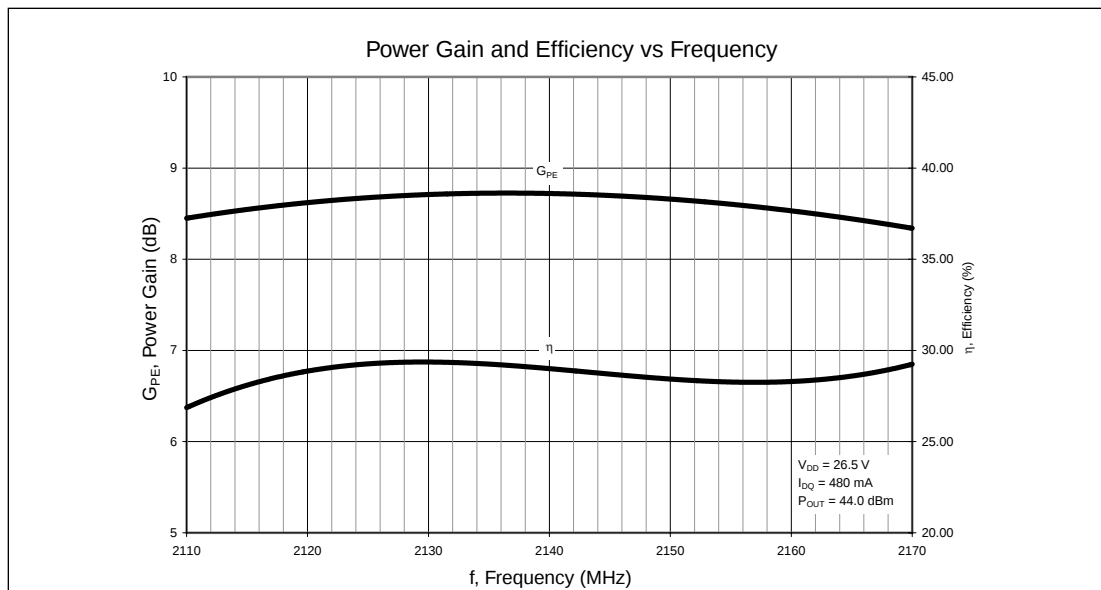
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Intermodulation Distortion vs Output Power

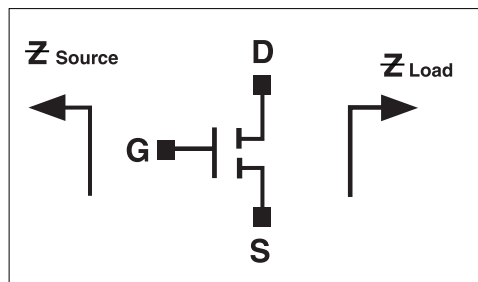


Power Gain & Efficiency vs Output Power





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$V_{DD} = 26.5V$
 $I_{DQ} = 480mA$

Frequency (MHz)	Z Source	Z Load
2100	1.33 - j4.25	.70 - j2.68
2120	1.31 - j4.20	.69 - j2.61
2140	1.29 - j4.15	.68 - j2.55
2160	1.28 - j4.11	.67 - j2.48
2180	1.26 - j4.06	.66 - j2.42
2200	1.24 - j4.02	.65 - j2.35

DC Safe Operating Area

